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PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Yasuhiro OMURA et al.

Group Art Unit: 2851

Application No.: 09/769,832

Examiner: R. FULLER

Filed: January 26, 2001

Docket No.: 108455

For: PROJECTION EXPOSURE APPARATUS AND METHOD, CATADIOPTRIC OPTICAL SYSTEM AND MANUFACTURING METHOD OF DEVICES

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference(s) listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference(s) be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- ☒ 1. This Information Disclosure Statement is being filed before the mailing date of a first Office Action on the merits after the filing of a Request for Continued Examination under 37 CFR §1.114. No certification or fee is required.
- ☒ 2. Translations of previously-submitted references are attached.

Respectfully submitted,

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MAC/cxm

Date: October 2, 2006

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Sheet 1 of 1

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 108455		APPLICATION NO. 09/769,832	
INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)				APPLICANT(S) Yasuhiro OMURA et al.			
				FILING DATE January 26, 2001		GROUP 2851	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
FOREIGN PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
	1	JP-A-6-250074	9-9-1994	JAPAN		x	
	2	JP-A-6-265789	9-22-1994	JAPAN		x	
	3	JP-A_6-349699	12-22-1994	JAPAN		x	
	4	JP-A-7-168116	7-4-1995	JAPAN		x	
	5	JP-A-9-312254	12-2-1997	JAPAN		x	
	6	JP-A-11-84199	3-26-1999	JAPAN		x	
	7	JP-A-11-194479	7-21-1999	JAPAN		x	
	8	JP-A-11-231192	8-27-1999	JAPAN		x	
	9	JP-A-2000-12453	1-14-2000	JAPAN		x	
	10	JP-A-2000-28898	1-28-2000	JAPAN		x	
	11	JP-A-2000-29202	1-28-2000	JAPAN		x	
	12	JP-A-2000-47114	2-18-2000	JAPAN		x	
OTHER DOCUMENTS							
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
EXAMINER					DATE CONSIDERED		
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: October 2, 2006